# VAX 10000 Advanced Troubleshooting

Order Number EK-1001A-TS.001

This manual is intended for Digital customer service engineers and selfmaintenance customers. It covers system troubleshooting information.

digital equipment corporation maynard, massachusetts

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# Contents

Preface	i
---------	---

# Chapter 1 Troubleshooting During Power-Up

1.1	Power System Overview	1-2
1.2	Power-Up Troubleshooting Flowchart	1-4
1.3	AC Input Box	1-6
1.4	H7263 Power Regulators	1-8
1.5	Cabinet Control Logic Module	1-10
1.6	Control Panel	1-12
1.7	Blower	1-14
1.8	XMI Plug-In Unit	1-16
1.9	Troubleshooting the XMI Plug-In Unit	1-18

# Chapter 2 System Self-Test

2.1	System Self-Test Overview 2-2
2.2	Power-Up Sequence
2.3	System Self-Test Results 2-10
2.4	Checking Self-Test Results: Console Display 2-12
2.4.1	Processor Fails Self-Test in a Uniprocessor System 2-14
2.4.2	Processor Fails ST1 in a Multiprocessor System 2-16
2.4.3	Processor Fails ST2 or ST3 in a Multiprocessor
	System 2-18
2.4.4	Memory Fails Self-Test 2-20
2.4.5	System Fails Power-Up Exerciser
2.5	Checking Self-Test Results: Status LEDs 2-24
2.5.1	Processor LEDs 2-26
2.5.2	Determining Failing Test Number from LEDs
2.5.3	IOP, DWLMA, and Clock Card LEDs 2-30

# **Chapter 3 Diagnostics**

3.1	Test Command	3-2
3.2	Running ROM-Based Diagnostics on XMI Devices	3-4
3.3	Running Diagnostics on DUP-Based Devices	3-8
3.3.1	Testing an SI Device	3-8
3.3.2	Testing a DSSI Device	3-12

# Appendix A Parse Trees

A.1	Reading Parse Trees	A-2	2
-----	---------------------	-----	---

# Appendix B Power System Troubleshooting

B.1	Getting Information on Power Regulator Status	B-2
B.1.1	Brief Data Packet	B-3
B.1.2	Full Data Packet	B-5
B.2	Show Power Command	B-11
B.3	Checking the IOP Module During Power-Up	B-11
B.4	Identifying an LSB Module Power Converter Failure	B-13

## Examples

2-1	Self-Test Display	-12
2-2	Console Display: Processor Fails in Uniprocessor System 2	-14
2-3	Console Display: Processor Fails ST1 in Multiprocessor System	-16
2-4	Console Display: Processor Fails ST2 or ST3 in a Multiprocessor System	-18
2-5	Console Display: Memory Fails Self-Test 2	-20
2-6	Console Display: Sample Unexpected Exception/Interrupt	-22
2-7	Console Display: Sample Diagnostic Error Report	-23
3-1	Test Commands	3-2
3-2	Sample RBD Session, Test Passing	3-4
3-3	Sample RBD Session, Test Failing	3-6
3-4	Testing an SI Device	3-8
3-5	Testing a DSSI Device	-12
A-1	Sample Machine Check, MCHK Code 06	<b>A-2</b>
B-1	Sample Output, Show Power CommandB	-11

# Figures

1-1	Power System 1-2
1-2	Power-Up Sequence 1-4
1-3	AC Input Box 1-6
1-4	AC Input Box Troubleshooting Steps1-7
1-5	H7263 Power Regulator LEDs 1-8
1-6	H7263 Power Regulator Troubleshooting Steps 1-9
1-7	CCL Module LEDs 1-10
1-8	CCL Module Troubleshooting Steps 1-11
1-9	Control Panel 1-12
1-10	Control Panel Troubleshooting Steps 1-13
1-11	Blower 1-14
1-12	Blower Troubleshooting Steps 1-15
1-13	XMI Plug-In Unit LEDs 1-16
1-14	XMI PIU Troubleshooting Steps - 48V LED Off 1-18
1-15	XMI PIU Power Connector 1-19
1-16	XMI PIU Troubleshooting Steps - MOD OK LED Off 1-20
2-1	KA7AA Power-Up Sequence, Part 1 of 3 2-4
2-2	KA7AA Power-Up Sequence, Part 2 of 3 2-6
2-3	KA7AA Power-Up Sequence, Part 3 of 3 2-8
2-4	Determining Self-Test Results 2-10
2-5	Processor and Memory Status LEDs 2-24
2-6	Processor LEDs After Self-Test 2-26
2-7	IOP, DWLMA, and Clock Card LEDs 2-30
A-1	KA7AA Machine Check Parse TreeA-4
A-2	KA7AA Hard Error InterruptsA-11
A-3	KA7AA Soft Error InterruptsA-19
A-4	IOP Interrupts
A-5	DWLMA Interrupts
B-1	Command Packet StructureB-2
B-2	Brief Data Packet Structure
B-3	Full Data Packet StructureB-5
B-4	Full Data Packet: Values for Characters 1-6B-6
B-5	Full Data Packet: Values for Characters 7-34B-7
B-6	Full Data Packet: Values for Characters 35-47B-8
B-7	Full Data Packet: Values for Characters 48-54B-9
B-8	IOP ModuleB-12
B-9	IOP Oscillator Switch SettingsB-13

# Tables

1

VAX 10000 Documentationviii	
-----------------------------	--

1-1 Power Regulator LED Summary	1-8
1-2 Control Panel LEDs During Power-Up	1-13
1-3 XMI PIU Power Regulator LEDs	1-17
1-4 XMI PIU Power Switches - Regulator B	1-17
2-1 System Testing	2-2
2-2 Test Numbers Indicated by KA7AA LEDs	2-28
2-3 DWLMA LEDs	2-31
3-1 Exercisers	3-3
B-1 Sample Brief Packet Information	B-3
B-2 Sample Full/History Packet Information	B-10
B-3 LED Status When a Power Converter Fails	B-13

# Preface

## **Intended Audience**

This manual is written for Digital customer service engineers and selfmaintenance customers.

## **Document Structure**

This manual uses a structured documentation design. Topics are organized into small sections for efficient on-line and printed reference. Each topic begins with an abstract. You can quickly gain a comprehensive overview by reading only the abstracts. Next is an illustration or example, which also provides quick reference. Last in the structure are descriptive text and syntax definitions.

This manual has three chapters and two appendixes, as follows:

- **Chapter 1, Troubleshooting During Power-Up,** explains what can go wrong during power-up and how to identify the cause of the problem.
- **Chapter 2, System Self-Test,** tells how to interpret the self-test console display and module LEDs.
- **Chapter 3**, **Diagnostics**, describes the various diagnostics used to test the system.
- **Appendix A** contains the parse trees, and **Appendix B** contains guidelines for troubleshooting the power system.

## **Conventions Used in This Document**

The text shown in command syntax uses these conventions:

- Bold text indicates elements to be typed at the terminal. •
- Brackets ([]) indicate that an element is optional. •
- Braces ({}) indicate a choice from the enclosed list.
- Angle brackets (<>) indicate that the enclosed text is not a literal depiction of the element but instead a reference to the kind of item that can appear in that position.

Icons such as those shown below are used in illustrations for designating part placement in the system described. A shaded area in the icon shows the location of the component or part being discussed.



## **Document Titles**

Table 1 lists the books in the VAX 10000 documentation set. Table 2 lists other documents that you may find useful.

Table 1	VAX 10000 Documentation
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Title	Order Number
Installation Kit	EK-1000A-DK
Site Preparation Guide	EK-1000A-SP
Installation Guide	EK-100EA-IN
Hardware User Information Kit	EK-1001A-DK
Operations Manual	EK-1000A-OP
Basic Troubleshooting	EK-1000A-TS

Title	Order Number
Service Information Kit	EK-1002A-DK
Pocket Service Guide	EK-1000A-PG
Advanced Troubleshooting	EK-1001A-TS
Platform Service Manual	EK-1000A-SV
System Service Manual	EK-1002A-SV
Reference Manuals	
Console Reference Manual	EK-70C0B-TM
KA7AA CPU Technical Manual	EK-KA7AA-TM
MS7AA Technical Manual	EK-MS7AA-TM
I/O System Technical Manual	EK-70I0A-TM
Platform Technical Manual	EK-7000A-TM
Upgrade Manuals	
KA7AA CPU Installation Card	EK-KA7AA-IN
MS7AA Memory Installation Card	EK-MS7AA-IN
DWLMA XMI PIU Installation Guide	EK-DWLMA-IN
H7237 Battery PIU Installation Guide	EK-H7237-IN
BA654 Disk PIU Installation Guide	EK-BA654-IN
DWMBB VAXBI PIU Installation Guide	EK-DWMBB-IN
Removable Media Installation Guide	EK-TFRRD-IN

### Table 1 VAX 10000 Documentation (Continued)

### Table 2 Related Documents

Title	Order Number
General Site Preparation	
Site Environmental Preparation Guide	EK-CSEPG-MA
System I/O Options	
CIXCD Interface User Guide	EK-CIXCD-UG
DEC FDDIcontroller 400 Installation/Problem Solving	EK-DEMFA-IP
DEC LANcontroller 400 Installation Guide	EK-DEMNA-IN
DEC LANcontroller 400 Technical Manual	EK-DEMNA-TM
DSSI VAXcluster Installation and Troubleshoot- ing Manual	EK-410AA-MG
InfoServer 150 Installation and Owner's Guide	EK-INFSV-OM
KFMSA Module Installation and User Manual	EK-KFMSA-IM
KFMSA Module Service Guide	EK-KFMSA-SV
RF Series Integrated Storage Element User Guide	EK-RF72D-UG
TF85 Cartridge Tape Subsystem Owner's Manual	EK-OTF85-OM
Operating System Manuals	
VMS Upgrade and Installation Supplement: VAX 7000-600 and VAX 10000-600 Series	AA-PRAHA-TE
VMS Network Control Program Manual	AA-LA50A-TE
VAXclusters and Networking	
HSC Installation Manual	EK-HSCMN-IN
SC008 Star Coupler User's Guide	EK-SC008-UG
VAX Volume Shadowing Manual	AA-PBTVA-TE
Peripherals	
Installing and Using the VT420 Video Terminal	EK-VT420-UG
LA75 Companion Printer Installation and User Guide	EK-LA75X-UG

# Chapter 1

# **Troubleshooting During Power-Up**

This chapter gives troubleshooting information on the power system. Sections include:

- Power System Overview
- Power-Up Troubleshooting Flowchart
- AC Input Box
- H7263 Power Regulators
- Cabinet Control Logic Module
- Control Panel
- Blower
- XMI Plug-In Unit
- Troubleshooting the XMI Plug-In Unit

## 1.1 Power System Overview

In general, the power system (Figure 1-1) consists of AC input boxes, DC distribution boxes, power regulators, and battery plugin units.



Figure 1-1 **Power System** 

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#### AC Input Box

Each system and expander cabinet has an AC input box. It provides the interface to the AC utility power via a three-phase, five-wire connector with attached power cord. The AC input box also contains the main input circuit breaker and fuses, and a power line monitoring port.

#### **DC Distribution Box**

Each system and expander cabinet has a DC distribution box. It provides the interconnect for the AC input box and power regulators. It also functions as the:

- Distribution point for 48 VDC system power
- Battery pack interface to the power regulators
- Signal interconnect from the CCL module to the power regulators

#### **Power Regulators**

Each system and expander cabinet has three power regulators operating in parallel, two units required for the load and the third used as a backup unit. Each power regulator provides the following:

- 48 VDC output
- LPS OK <A:C>L signal
- Power system status via serial data lines
- Non-switched 48 VDC power to the CCL module
- Status indicators for fault isolation
- Battery charging and monitoring circuitry
- Battery backup converter

### **Battery Plug-In Units (PIUs)**

Battery PIUs are contained in the bottom of the system cabinet and in the battery cabinet(s). Battery PIUs provide uninterrupted power in the event of a power failure. The combination of two battery PIUs in a system or battery cabinet provides backup for the cabinet's three regulators, labeled A, B, and C. Eight batteries support each regulator.

For more information:

**Platform Service Manual** 

## 1.2 Power-Up Troubleshooting Flowchart









Figure 1-2 Power-Up Sequence (Continued)

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## 1.3 AC Input Box

The AC input box with circuit breaker is located in the upper rear of a system or expander cabinet. The circuit breaker has four indicators (see Figure 1-3). All four indicators should be RED when the circuit breaker is in the On position.





The AC input box accepts three-phase power; the three leftmost indicators on the circuit breaker show the state of each pole (one phase per pole). If an indicator is green, the pole is in the Off position or tripped due to an overload. If an indicator is red, the pole is in the On position and is not tripped. The fourth rightmost indicator reflects the mechanical position of the circuit breaker. This indicator is red when the circuit breaker is in the On position and green when the circuit breaker is in the Off position.

Figure 1-4 shows the troubleshooting steps for the AC input box.







## 1.4 H7263 Power Regulators

The H7263 power regulators are located in the upper right front of the cabinet. Each power regulator has a Run LED and a Fault LED (see Figure 1-5).

### Figure 1-5 H7263 Power Regulator LEDs



 Table 1-1
 Power Regulator LED Summary

Run (Green)	Fault (Yellow)	Condition
Off	Off	No AC power present
Off	On	Fatal fault
Fast flash	Off	AC power present. Keyswitch in Disable position.
On	Fast flash	Nonfatal fault
On	Slow flash	Battery discharge mode
On	Off	Normal operation





NOTE: Replace the power regulator if the LEDs indicate a fatal fault.

Nonfatal faults include:

- Internal heatsink temperature warning
- Power factor correction stage failed
- Regulator/battery failed battery test (see Appendix B)
- 48V to CCL module exceeds specified limits

### 1.5 Cabinet Control Logic Module

The cabinet control logic (CCL) module is located in the upper front of the cabinet, behind the control panel. The CCL module controls power sequencing and is wired to the control panel, DC distribution box, LSB backplane, blower, PIUs, optional removable media, and expander cabinets. The module has a power LED and four PIU enable LEDs. You can see the CCL LEDs from the rear of the cabinet when the rear door is open.





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During power sequencing, the CCL power LED goes on to indicate that power is present on the module. A PIU LED goes on to indicate that a PIU is present in the quadrant and that its power regulators are enabled. Figure 1-8 shows the troubleshooting steps for the CCL module.





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## 1.6 Control Panel

The control panel has a keyswitch and three indicator LEDs. To power up the system, you turn the keyswitch to Enable.



### Figure 1-9 Control Panel

The control panel LEDs are powered by the CCL module. Table 1-2 lists the state of each control panel LED during a normal power-up. Figure 1-10 shows troubleshooting steps for the control panel.

Table 1-2 Control Panel LEDs During Power-Up

Action	Key On	Run	Fault
Set circuit breaker to On	Off	Off	Off
Set keyswitch to Enable	On	Off	Slow Blink
Self-test starts	On	Off	On
Modules pass self-test	On	Off	Off
Operating system boots	On	On	Off

Figure 1-10 Control Panel Troubleshooting Steps



*NOTE:* The Fault LED blinks fast for 8 seconds to indicate a failure at power-up. Then the Fault LED blinks slowly until the failure condition is cleared.

## 1.7 Blower

The blower is located in the center of the cabinet. The blower spins up when you turn the keyswitch to Enable.

### Figure 1-11 Blower



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Figure 1-12 shows the troubleshooting steps for the blower.

*NOTE:* If the blower spins up but the control panel Fault LED blinks for more than 30 seconds, check the BLOWER OK signal cable. If the signal cable is properly connected, then replace the CCL module.





### 1.8 XMI Plug-In Unit

The XMI plug-in unit has two power regulators with indicator LEDs and switches. You can see the power regulators through the PIU enclosure when the front cabinet door is open.

Figure 1-13 XMI Plug-In Unit LEDs



LED	Color	State	Meaning
MOD OK	Green	On Off	Regulator is working Regulator is not working or V-OUT/DISABLE switch is set to DISABLE (down).
48V	Green	On	48V is present
OC <sup>1</sup>	Yellow	On	Overcurrent condition
OT <sup>1</sup>	Yellow	On	Overtemperature condition
OV <sup>1</sup>	Yellow	On	Overvoltage condition
<sup>1</sup> The OC, OT, and OV LEDs are latching indicators. Each LED indicates that a fault con- dition was or is present. The condition may have been cleared, but the LED remains lit until it is reset.			

### Table 1-3 XMI PIU Power Regulator LEDs

### Table 1-4 XMI PIU Power Switches - Regulator B

Switch	Function	
RESET	Momentary switch resets all LEDs on both regulators.	
	<i>NOTE:</i> If resetting does not clear the OC, OT, or OV LED, shut off the regulators and reapply power. This action should clear the LED.	
V-OUT DISABLE	Power output for both regulators is enabled when this switch is in the V–OUT position (up). Power output is shut off when this switch is in the DISABLE position (down).	

## 1.9 Troubleshooting the XMI Plug-In Unit

Figure 1-14 and Figure 1-15 show the steps to take if the power regulator 48V LED indicates a power problem. If the MOD OK LED indicates a problem, see Figure 1-16.



Figure 1-14 XMI PIU Troubleshooting Steps - 48V LED Off

Figure 1-15 XMI PIU Power Connector





### Figure 1-16 XMI PIU Troubleshooting Steps - MOD OK LED Off

# Chapter 2

# System Self-Test

This chapter describes self-test. Sections include:

- System Self-Test Overview
- Power-Up Sequence
- System Self-Test Results
- Checking Self-Test Results: Console Display
  - Processor Fails Self-Test in a Uniprocessor System
  - Processor Fails ST1 in a Multiprocessor System
  - Processor Fails ST2 or ST3 in a Multiprocessor System
  - Memory Fails Self-Test
  - System Fails Power-Up Exerciser
- Checking Self-Test Results: Status LEDs
  - Overview of Processor LEDs
  - Determining Failing Test Number from LEDs
  - IOP, DWLMA, and Clock Card LEDs

## 2.1 System Self-Test Overview

When the system is powered up or reset, a series of tests is run. Table 2-1 lists the tests run during system testing.

### Table 2-1 System Testing

Test Level	Test	Number of Tests
1	SROM tests	11
2	Gbus ROM tests	45
3	CPU/memory tests	10
4	Multiprocessor tests	7
5	IOP tests	17
6	DWLMA tests	18
7	Power-up exerciser	Not applicable

### Level 1 - SROM Tests

The first phase of CPU self-test consists of 11 SROM tests. This initial group of diagnostics is loaded from serial ROM into the CPU's primary cache on power-up. The diagnostics are then executed from the primary cache; access to the backup cache is verified, and then the backup cache is tested.

#### Level 2 - Gbus ROM Tests

The Gbus ROM tests, stored in FEROM, are executed during the second phase of the CPU self-test. These tests continue CPU testing.

#### Level 3 - CPU/Memory Tests

These tests verify CPU logic that cannot be tested without memory. The CPU/memory tests also test memory logic that is not tested during the module self-test.

### Level 4 - Multiprocessor Tests

Multiprocessor tests are executed by CPUs that have passed both self-test and CPU/memory testing. These tests verify CPU-specific logic that is not tested during previous test levels.

#### Level 5 - IOP Tests

The boot processor runs tests on the IOP module.

### Level 6 - DWLMA Tests

The boot processor runs tests on all DWLMA I/O adapters.

#### Level 7 - Power-Up Exerciser

All CPUs run the power-up exerciser.

#### For more information:

KA7AA CPU Technical Manual

### 2.2 Power-Up Sequence

Figure 2-1 shows the power-up sequence for the KA7AA processors. All processors execute three test phases and a boot processor is designated after each test phase. The boot processor tests the IOP module and DWLMA adapters and prints the self-test display.





● All CPUs and memories execute their on-board self-test at the beginning of the power-up sequence. On line ST1 of the self-test display, a plus sign (+) is shown for every module that passes self-test.

**2** The boot processor is determined. On the first **BPD** line, the letter **B** corresponds to the processor selected as boot processor. Because the processors have not yet completed their power-up tests, the designated processor may later be disqualified from being boot processor. For this reason, line **BPD** appears three times in the self-test display.

The boot processor prints the results of self-test, lines NODE #, TYP, ST1, and BPD on the self-test display. The boot processor then signals all CPUs to start running the CPU/MEM tests.

▲ All CPUs execute the CPU/MEM tests using the memories. On line ST2 of the self-test display, a plus sign (+) is shown for every module that passes the CPU/MEM test. If all CPUs pass the CPU/MEM tests, then the original boot processor selection is still valid.

**(3** The boot processor is again determined, for the second time. Results are printed on the **BPD** line.




**6** The boot processor prints line **ST2** and the second **BPD** of the self-test display. If no processor is selected as the boot processor, an error message is displayed and the console hangs (see Section 2.4.1).

 All passing CPUs execute the multiprocessor tests. On line ST3 of the self-test display, a plus sign (+) is shown for every module that passes the multiprocessor tests. If all CPUs pass the multiprocessor tests, then the original boot processor selection is still valid.

**③** The boot processor is again determined, for the third time. Results are printed on the **BPD** line.

The boot processor copies the console to memory and begins executing in multiprocessor mode. Next, the boot processor prints the results of the multiprocessor tests on the ST3 line and then executes the IOP tests.





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- **①** DWLMA adapter test results are indicated on the lines labeled **C0 XMI** to **C3 XMI** on the self-test display. A plus sign (+) at the extreme right means that the adapter passed; a minus sign (-) means that the adapter failed. IOP test results are indicated on line **ST3**.
- **1** If the DWLMA adapter passes its self-test, then the boot processor reports the self-test results for each XMI adapter.
- Testing continues. All CPUs execute the power-up exercisers. Specific exercisers test the following:
  - Cache/memory
  - Floating point
  - Network
  - Disk (internal loopback only)

### 2.3 System Self-Test Results

### The results of self-test can be determined in three ways.





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There are three ways to check the results of self-test:

- **Control panel Fault LED.** This LED remains lit if a processor, a memory, an IOP module, or an XMI adapter fails self-test.
- **Module LEDs.** The LEDs on the LSB modules display the results of self-test, as described in Section 2.5.
- **Console terminal**. A summary report of self-test appears on the console terminal. This summary report is described in Section 2.4.

### 2.4 Checking Self-Test Results: Console Display

The console display gives the results of module self-tests and additional testing.

#### Example 2-1 Self-Test Display

F	E	Л	C	в	Δ	9	8	7	6	5	4	З	2	1	0	NODE #	
-	-	D	C	D		-	7	у	Ũ	5	-	5	2	- -	л П		5
							А	Ivi	·	·	·	•	•	Р	Р	IIP	2
							0	+	•	·	·	•	·	+	+	ST1	)
							•	•	•			•	•	Е	В	BPD 4	)
							0	+						+	+	ST2	•
														Е	В	BPD	
							+	+						+	+	ST3	•
							•	•	•	•	•			Ε	В	BPD	
																	_
	•	•	•	•	•	•	•	•	•	•	•	•	•	•		CO XMI -	7
	+			•			+					-				Cl XMI +	•
																C2	
	•			•		•	•		•				•			C3 1	D
								۸O								TLV	
							•	250	•	·	·	•	•	•	•		
						_	•	200	•	•	•	•	•	•	•		
			_		1	~				_		1	~	~ ~		an- a- a1 a a 4	

Firmware Rev = V1.0-1625 SROM Rev = V1.0-0 SYS SN = GA01234567 🕧 P00>>>

1 The first line lists the node numbers on the LSB and XMI I/O buses.

- 2 This line indicates the type of module at each LSB node. Processors are type P, memories are type M, and the IOP module is type A. In this example processors are at nodes 0 and 1, a memory is at node 7, and the IOP module is at node 8.
- **3** This line shows the results of on-board self-test. Possible values for processors are pass (+) or fail (-). For memories, the pass (+) value indicates successful completion of self-test. (Self-test failure indications are shown in Example 2-2 and Example 2-3.) The "o" at node 8 (IOP module) indicates no on-board self-test.

The BPD line indicates boot processor designation. When the system completes on-board self-test, the processor with the lowest LSB ID number that passes self-test and is eligible is selected as boot processor. This process occurs again after ST2 and ST3 when the boot processor designation is reported on the second and third BPD lines.

During the second round of tests (ST2), all processors run CPU/MEM tests. On line ST2, results are reported for each processor and memory; a plus sign (+) indicates that ST2 testing passed and a minus sign (-) that ST2 testing failed. The boot processor is again reported on the BPD line.

**6** During the third round of tests (ST3), all processors run multiprocessor tests. Results are reported on line ST3, and the boot processor designation is again reported on the third and final BPD line.

✔ A minus sign (-) at the right of the C0 XMI line means that the DWLMA adapter on I/O channel 0 failed self-test. Self-test results for adapters on this I/O channel will not be reported.

A plus sign (+) at the right of the C1 XMI line indicates that the DWLMA adapter on I/O channel 1 passed self-test. However, the adapter at XMI node 3 failed its own self-test. I/O channels C2 ( ) and C3 ( ) are not used in this configuration.

The last line of the self-test display shows the console firmware and SROM version numbers and the system serial number.

For more information:

Basic Troubleshooting

### 2.4.1 Processor Fails Self-Test in a Uniprocessor System

When the processor in a uniprocessor system fails self-test, the operator is prompted for the slot number of the processor. Where the error message appears in the console display indicates the round of tests the processor failed: ST1, ST2, or ST3. See Example 2-2.

>>> i	nit														
CPU00	: т	est	Fai	ilu	re	- S	ele	ct	pri	mar	y C	PU			0
F E	D	С	В	А	9	8	7	6	5	4	3	2	1	0	NODE #
						А	М							Ρ	TYP
						0	+							-	ST1
														В	BPD
CPU00	CPU00: Test Failure - Select primary CPU 🚺														
						0	+							-	ST2
														В	BPD
CPU00	CPU00: Test Failure - Select primary CPU														
						+	+							-	ST3
														В	BPD
				+		+	•	+				+			CO XMI +
				+		+		+				+			Cl XMI +
								•							C2
															C3
							A0					•			ILV
						.2	56					•			256Mb
Firmw	are	Rev	v =	V1	.0-	-162	5 SI	ROM	1 Re	v =	V1	.0-	0 S	YS	SN = GA01234567
>>>															

### Example 2-2 Console Display: Processor Fails in Uniprocessor System

Example 2-2 shows a processor failure in a uniprocessor system.

The error message, CPU00: Test Failure - Select primary CPU, prompts you to enter the node ID of the failing processor. Note that the CPU node ID appears in the error message (CPU00). Type 0 to obtain the full console display. If you do not type the node ID when prompted, the processor continues to hang.

## *NOTE:* The user input in response to the error message is not echoed at the console terminal.

### **Possible Solutions**

- Move the processor to another slot and retry self-test.
- Replace the failing processor with a new processor (see the *System Service Manual*).

### 2.4.2 Processor Fails ST1 in a Multiprocessor System

When a processor in a multiprocessor system fails self-test at ST1, no failure information is reported to the console display. Only passing processors show in the console display.

Example 2-3					Console Display: Processor Fails ST1 in Multiprocessor System														
F	Е	D	С	В	A	9	8	7	б	5	4	3	2	1	0	1 NO	DE #		
							А	М	М				•	Ρ		TY	Ρ		
							0	+	+				•	+		ST	1		
								•	•	•	•	•	•	В		BPI	D		
							0	+	+	•	•	•	•	+	•	ST	2		
							•	•	•	•	•	•	•	В	•	BPI	D		
							+	+	+	•	•	•	•	+	•	ST	3		
							•	•	•	•	•	•	•	В	•	BPI	D		
					+		+	•	+				+			C0	XMI	+	
	•	•	•	•	+	•	+	•	+	•	•	•	+	•		C1	XMI	+	
	•	•	•	•	•	•	•	•	•	•	•	•	•	•		C2			
	•	•	•	•	·	•	•	•	•	•	•	•	•	·		C3			
							.2	A1 562	A0 56				•			IL 51	V 2Mb		
Fi:	rmwa	are	Re	v =	V1	.0-	162	5 S	ROM	Re	v =	V1	.0-	0 S	YS	SN :	= GA	0123	4567

#### >>>

When a processor fails ST1 testing in a multiprocessor system, no information is reported, and the failing processor is logically disconnected from the backplane to prevent faulty system operation. Dots are displayed, as though no processor were physically present.

In this example the processor in slot 0 fails ST1 (see ①). If the processor in slot 1 failed ST1, then the column for slot 1 would report no information.

To confirm a processor failure at ST1, open the LSB card cage and check the module positions against the self-test display. If you find a processor occupying a slot that is not reporting to the self-test display, check the CPU LED lights for test failure information.

### **Possible Solutions**

- Check module seating in the LSB card cage. Remove the failing module and re-insert it; check that the module case is in the tracks and latched securely.
- Place a passing processor in the failing slot; if the passing processor fails, you may have a bad LSB slot. Next, take the failing module and try it in a slot where a module has passed self-test. If the failing processor now passes self-test, avoid using the slot in which both processors failed testing.
- Replace the failing processor with a new processor (see the *System Service Manual*).

### 2.4.3 Processor Fails ST2 or ST3 in a Multiprocessor System

Example 2-4 shows a multiprocessor system with ST2 and ST3 failures. Since ST2 is a CPU/memory test, the example shows a memory failure to illustrate the CPU/memory interaction.

Exa	am	ple	2-	4	Console Display: Processor Fails ST2 or ST3 in a Multiprocessor System											3 in a	
F	Е	D	С	в	А	9	8	7	6	5	4	3	2	1	0	NODE #	
							А	М	М			•	Ρ	Ρ	Ρ	TYP	
							0	+	+				+	+	+	ST1	0
							•		•		•	•	Е	Е	В	BPD	
							0	+	+			•	+	+	-	ST2	0
							•		•		•	•	Е	В	Е	BPD	
							+	+	+			•	+	-	-	ST3	3
							•	•	•	•	•	•	В	Ε	Ε	BPD	
					+		+		+				+			CO XMI	+
	•	•			+	•	+		+		•	•	+			C1 XMI	+
	•	•					•		•			•		•		C2	
	•	•	•	•	•	•	•	•	•	•	•	•	•	•		C3	
							. 7	A1 <i>I</i>	70							ILV	
							.25	5625	56	•	•	•	•	•	•	512Mb	
Fir	Firmware Rev =					.0-1	1625	5 SF	ROM	Rev	- =	V1.	. 0 - 0	) SI	ľS	SN = GAC	01234567
P02	2>>>	>															

Processors can fail ST1, ST2, or ST3 testing. When a processor fails ST1 or ST2, subsequent ST lines will also indicate failure.

- **1** The ST1 line shows that each of the three CPUs passed the first round of testing. The two memories successfully completed ST1 also.
- ST2 is the CPU/memory test. The ST2 line shows the CPU in slot 0 failing. Consequently, the failing CPU is no longer designated as the boot processor. The CPUs in slots 1 and 2 conduct the CPU/memory tests. The memories in slots 6 and 7 pass ST2 testing.
- Only the CPUs in slots 1 and 2 undergo ST3 testing; the processor in slot 0 is not tested because of its previous failure during ST2 testing. In the example, the CPU in slot 1 fails the third round of testing.

### **Possible Solutions**

- Reseat processors in slots 0 and 1 and repeat testing.
- Place passing CPU in failing slot and if the passing CPU fails, you may have a bad LSB slot. Next, take the failing CPU and try it in a slot where a module has passed self-test. If the failing CPU now passes self-test, avoid using the slot in which both processors failed testing.
- Replace the failing processor with a new processor (see the *System Service Manual*).

### 2.4.4 Memory Fails Self-Test

# A minus sign (-) at ST1 indicates that the on-board self-test was unable to complete. A minus sign at ST2 or ST3 following a plus sign (+) at ST1 indicates errors in the CPU/memory tests.

### Example 2-5 Console Display: Memory Fails Self-Test

F	Е	D	С	В	A	9	8	7	6	5	4	3	2	1	0	NODE #
							А	M	М					Ρ	Ρ	TYP
							0	_ •	+		•			+	+	ST1
								•	· ·					Е	В	BPD
							0	_4	9+					+	+	ST2
							•	•	· ·	•	•	•	•	Е	В	BPD
							+	_6	9+		•			+	+	ST3
							•			•	•	•	•	Е	В	BPD
	•	•	•		+	•	+		+	•	•		+			CO XMI +
	•	•		•	+	•	+	•	+	•	•	•	+	•		C1 XMI +
	•	•		•	•	•	•	•	•	•	•	•		•		C2
	•	•	•	•	•	•	•	•	•	•	•	•	•	•		C3
											•					
							. E	30	A0	•	Ŷ		•		•	ILV
							2	562	256			•				512Mb
Firmware Rev = V1.0-1625 SROM Rev = V1.0-0 SYS SN = GA01234567																
P00	)>>>	>														

At power-up or reset, each memory module executes a self-test designed to test and initialize its RAMs. The self-test performs a quick scan of the DRAM array and records sections of the array that contain defective locations. These sections will eventually be mapped out by the console and will no longer be included in the console bitmap. The operating system uses this bitmap to determine which memory to use and not to use.

The memory self-test does not provide a pass/fail status. The module LED indicates only that self-test completed. The length of testing depends on the size of the memory array.

In Example 2-5:

- The failure reported at ST1 indicates that the memory module at node 7 is unable to complete its on-board self-test. Consequently, the self-test LED on the memory module remains unlit.
- 2 The CPU/memory tests are run on the passing memory at node 6. The failed memory at node 7 is not used during this testing. The ST2 line indicates that both processors and one memory module passed the CPU/memory test.

**3** The failing memory is not used during ST3 testing. The minus sign appears only to identify the memory as a failing FRU.

▲ The memories at nodes 6 and 7 are configured in the system. The memory at node 7, however, failed during ST1 and is put in an interleave set of its own.

### 2.4.5 System Fails Power-Up Exerciser

When the system fails the power-up exerciser, an error message is displayed at the console terminal. The error message is either an unexpected exception/interrupt (Example 2-6) or a diagnostic error report (Example 2-7), depending on the type of error found. See Appendix A for parse trees.

### Example 2-6 Console Display: Sample Unexpected Exception/Interrupt

CPU2: unexpected exception/interrupt, vector 60 (18) process entry\_02, pcb = 000dad60, pc: 0007feed psl: 0000004 Interrupt/Exception: hard error notification LMERR: 0000180 LMODE: 000102a0 LBER: 0004121f LLOCK: 00004430 LDEV: 00008002 LCNR: 00000001 LBESR0:0000000c LBESR1:0000000c LBESR2:0000000c LBESR3:0000000 LBECR0:1f555555 LBECR1:00001000 BIU\_CTL: afe09ff8 DIAG\_CTL: 0000001 BC\_TAG: 00003800 BIU\_STAT: f01e10a1 BIU\_ADDR:eaaaaaae FILL\_SYN: 00000000 FILL\_ADDR: 000002a8 gprs: 0: 0000001F 3: 0008E478 6: 0000002 9: 00088610 12: 000DBE8C 1: 0008E478 4: 0000000 7: 0000004 10: 0000000 13: 000DBE74 2: 0008E478 5: 0000000 8: 00083B10 11: 0000000 14: 0007FEED ksp: 000DBE74 esp: 0000000 ssp: 0000000 usp: 0000000

**1** A hard error (vector 60) was detected.

**2** These are the relevant error registers in the CPU bus interface gate array.

**3** These are the internal processor error registers (IPRs).

### Example 2-7 Console Display: Sample Diagnostic Error Report



- A hard error, error #23, is reported on FRU MS7AA1, a memory module. The three types of errors reported are hard, soft, and fatal. The error number, in this case error #23, corresponds to the location of the actual error report call within the source code for the failing diagnostic.
- **2** The process identification number (ID) is 8e. This is the process ID of the failing diagnostic.
- **3** The program running when the error occurred is mem\_ex, the memory exerciser.
- The device being tested at the time of the error. The device name in this field may or may not match the device mnemonic displayed in the FRU field (1).

**6** The current pass count, 6, is the number of passes executed when the error was detected.

The current hard error count is 1. The hard and soft error counts are the number of errors detected and reported by the failing diagnostic since the testing started.

- **7** The current soft error count is 0.
- 8 In this example, the failing test number is 1.
- **9** The time stamp shows when the error occurred.
- The expected and received values at failing address 010003d0 are reported.

### 2.5 Checking Self-Test Results: Status LEDs

You can check self-test results by looking at the status LEDs on the modules. The processor diagnostic LEDs are described in Section 2.5.1 and Section 2.5.2. The LEDs on the IOP module, DWLMA adapter, and clock card are described in Section 2.5.3.





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#### **Processor Status LEDs**

The large green LED at the bottom of the processor lights when the module passes self-test. You can see this LED through the peephole on the module enclosure.

To view the diagnostic LEDs on a failing processor:

- 1. Open the front door of the cabinet.
- 2. Release the plate covering the modules by loosening the two top screws.
- 3. Remove the opaque plastic window covering the diagnostic LEDs on the processor by pulling it out with your fingers.

Section 2.5.1 describes the diagnostic LEDs on the processor module.

#### Memory Status LEDs

A memory module has two green LEDs: a self-test completed LED and a power LED. The self-test completed LED lights when the module completes self-test. This LED is visible through the peephole on the module enclosure. The power LED lights to indicate that power is present on the module.

### 2.5.1 Processor LEDs

The processor LEDs display the results of self-test. You must remove the plate covering the card cage and the plastic window on the processor module to view the diagnostic LEDs.





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When self-test passes, the processor's LEDs are set as shown in Figure 2-6. The two LEDs closest to the self-test LED are on if the KA7AA is the boot processor; the LED closest to the self-test LED is on if the KA7AA is a secondary processor.

If self-test fails for the processor or the memory module fails, the top seven processor LEDs contain an error code that corresponds to the number of the failing test. The test number is represented in binary-coded decimal, with the most significant bit at the top. A bit is ONE if the light is ON.

For example, assume a processor fails its self-test (large green LED is OFF) and shows the following pattern in the top seven LEDs:

TOP (MSB) off 0 = 3 on 1 on 1 off 0 off 0 off 0 off 0 1 = 2 (LSB) off 0

#### BOTTOM

The failing test number decodes to 011 0010 (binary-coded decimal 32).

Section 2.5.2 gives more detail on the failing tests indicated by the processor LEDs.

### 2.5.2 Determining Failing Test Number from LEDs

When self-test fails, the top seven green LEDs on the processor indicate the test number. A failing test number is in binary-coded decimal.

### Table 2-2 Test Numbers Indicated by KA7AA LEDs

Test Number	Type of Test	Failing Device	Self-Test Line
1–11	SROM tests	KA7AA	ST1
12–59	GROM tests	KA7AA	ST1
60-69	CPU/memory tests	KA7AA or MS7AA	ST2
70–76	Multiprocessor tests	KA7AA	ST3

You can see the results of self-test from the LEDs on the processor.

### **KA7AA Self-Test LED Off**

If the processor's large green LED is off and the top seven small LEDs show an error code in the range of 1 to 59, then the processor's self-test failed and the processor board is bad.

After the on-board self-test, each processor that passes self-test runs the CPU/memory tests. The LEDs display error codes for failing CPU/memory tests with numbers ranging from 60 to 69. The self-test LED on the failing processor or the failing memory module is off.

Next, processors that pass both the on-board self-test and CPU/memory testing run multiprocessor tests. For failing multiprocessor tests, the LEDs display numbers ranging from 70 to 76. The self-test LED on the processor is off.

### KA7AA Self-Test LED On, IOP LED Off

The IOP module has failed testing if its LED is off. The self-test LED on the KA7AA will be on.

### 2.5.3 IOP, DWLMA, and Clock Card LEDs

Figure 2-7 shows the LEDs on the IOP module, the DWLMA adapter, and the clock card.





#### **IOP Module LED**

To view the IOP self-test LED, open the rear door of the cabinet and release the plate covering the card cage by loosening the two top screws. The green LED is on to indicate that the IOP passed self-test.

### **DWLMA Adapter LEDs**

Table 2-3 lists the DWLMA LEDs and their self-test passed status.

*NOTE:* If the DWLMA adapter fails self-test, check the clock card at node 7 in the XMI card cage. If the clock card fails testing (power LED is off), the DWLMA adapter will also fail.

### Table 2-3 DWLMA LEDs

LED	Color	Designated Condition
STP — Self-test passed	Yellow	On
DBGDIS — Debug disabled	Green	On
POK — Power OK	Green	On
FTLERR — Fatal error	Red	Off
ES — Error Summary	Red	Off

### **Clock Card**

The clock card, XMI node 7, has a yellow LED that lights to indicate that power is enabled in the XMI card cage. The POWER ENABLE H signal is looped through the clock card so that the XMI power system cannot be enbled unless the clock card is properly installed.

# Chapter 3

# Diagnostics

This chapter discusses how to test processors, memory, and I/O. Sections include:

- Test Command
- Running ROM-Based Diagnostics on XMI Devices
- Running Diagnostics on DUP-Based Devices
  - Testing an SI Device
  - Testing a DSSI Device

### 3.1 Test Command

The test command allows you to test the entire system, an I/O subsystem, a single module, a group of devices, or a single device.

### Example 3-1 Test Commands

P00>>>	test	<pre># Tests the entire system. # Default run time is 10 # minutes.</pre>
P00>>>	t xmi0 -t 60	<pre># Tests all devices # associated with the XMI0 # I/O subsystem. Test # run time is 60 seconds.</pre>
P00>>>	t xmil -omit "demna*"	<pre># Tests all devices # associated with XMI1 except # for Ethernet devices.</pre>
P00>>>	t -nowrite "dub*" -wr	te -t 120
		<pre># Do write/read/compare # testing on all disks not # associated with controller # b. Test run time is 120 # seconds.</pre>
P00>>>	t demna*	# Tests all DEMNA adapters.
P00>>>	t du*.0.4.0	<pre># Tests all MSCP disks # associated with the # adapter in slot 4 of # XMI0.</pre>
P00>>>	t -q	<pre># Status messages will not be # displayed during system # test.</pre>

You enter the command **test** to test the entire system using exercisers. No module self-tests are executed when the test command is issued without a mnemonic.

When you specify a subsystem mnemonic or a device mnemonic with **test** such as **test xmi0** or **test ka7aa1**, self-tests are executed on the associated modules first and then the appropriate exercisers are run. Table 3-1 lists the exercisers associated with each module.

The same set of tests that run at power-up will run if you enter a **test iop0** or a **test dwlma***n* command.

Module	Module Self-Test Run?	Exerciser
KA7AA	Yes	Floating-Point, Multiprocessor, Memory
MS7AA	No	Memory
CIXCD	Yes	Disk
DEMFA	Yes	Network
DEMNA	Yes	Network
KDM70	Yes	Disk
KFMSA	Yes	Disk
Disk Device	No	Disk

Table 3-1 Exercisers

*NOTE:* Testing tape devices is not supported by the **test** command. Run DUP-based tests to test an MSCP-based tape device. See Section 3.3.

### 3.2 Running ROM-Based Diagnostics on XMI Devices

Some XMI devices can be tested from the console terminal with their on-board ROM-based diagnostics (RBDs). The set host command is used to connect to the XMI device. Example 3-2 shows a passing RBD test display, and Example 3-3 shows a test failure display.

### Example 3-2 Sample RBD Session, Test Passing

```
P00>>> sh config 1
          Name
                       Type
                                   Rev
                                           Mnemonic
LSB
        KA7AA(8002)0000ka7aa0KA7AA(8002)0000ka7aa1MS7AA(4000)0000ms7aa0IOP(2000)0001iop0
0+

        (8002)
        0000
        ka7aa0

        (4000)
        0000
        ms7aa0

        (2000)
        0001
        iop0

1+
7+
8+
                                           xmi0
CO XMI
        DWLMA (102A) 0104 dwlma0
8+
C+
         KDM70
                       (0C22) 1E11 kdm700
                       (0C03)
         DEMNA
                                   0802 demna0 2
E +
P00>>> set h demna0 3
Connecting to remote node, ^Y to disconnect.
t/r 4
RBDE> ST0/TR 5
;Selftest
               3.00
; T0001 T0002 T0003 T0004 T0005 T0006 T0007 T0008 T0009 T0010
; T0011 T0012 T0013 T0014 T0015 T0016 T0017 T0018
         P 6
                  Е
                          0C03
;
                                        1
RBDE> ^Y 7
P00>>> 8
```

- **1** The **show configuration** command shows that this system includes a DEMNA at XMI0 node E.
- **2** The assigned mnemonic for the DEMNA is demna0.
- **3** The **set host demna0** command is typed at the console prompt. A connection is established to the DEMNA adapter. A message confirms that the connection has been made.
- ▲ After the console message no prompt is displayed. Typing t/r invokes the RBD monitor on the adapter being tested and returns the RBD monitor prompt. Note that the *E* in the RBD prompt refers to the XMI node.
- **5** The RBD is started with trace set.
- **6** This field indicates whether the RBD passed or failed; P for passed, F for failed.
- **7** Enter Ctrl/Y to exit from the RBD monitor.
- **3** The console prompt returns.

For more information:

VAX 6000 Model 600 Service Manual

### Example 3-3 Sample RBD Session, Test Failing

P00>>> set h demna0 1 Connecting to remote node, ^Y to disconnect. t/r RBDE> ST0/TR 2 ;Selftest 3.00 ; T0001 T0002 T0003 T0004 T0005 T0006 T0007 T0008 T0009 T0010 ; T0011 T0012 T0013 T0014 T0015 T0016 T0017 T0018 F 3 E 0C03 ; 1 he 👍 xnaga XX T0018 **5** ; 03 0000000 0000A000 0000000 20150004 20051D97 08 ; 6 0 E 0C03 F 8 1 ; ΗE XNAGA XX T0018 ; 05 00020000 80020000 00000000 20150204 200524A4 01 ; 0C03 ; F Е 1 🥑 Ð RBDE> ^Y P00>>>

- **1** The **set host demna0** command is typed to establish the connection to the DEMNA adapter. A message confirms that the connection has been made.
- **2** The RBD is started with trace set.
- **3** F indicates the first failure during T0018, or test 18.
- ▲ The class of error is displayed here. *HE* indicates that the error was a hard error. *SE* means that the error was a soft error, and *FE* indicates a fatal error.
- **5** This field lists the number of the test that failed; test 18 failed here.
- **6** The expected data is shown here. 00000000 is the data test 18 expected.
- **7** The received data is shown here. 0000A000 is the data test 18 received.
- 8 F indicates the second failure during test 18.
- S This is the summary line, and a repeat of the failure summary. It lists the pass/fail code (P or F), the node number and device type number of the device executing the RBD, and the number of passes of the RBD.
- **()** This is the number of hard errors detected.

#### For more information:

VAX 6000 Model 600 Service Manual

### 3.3 Running Diagnostics on DUP-Based Devices

To run diagnostics on a DUP-based device, enter the set host command to invoke the DUP server on the selected node. You can test devices associated with the KDM70 (SI) adapter or the KFMSA (DSSI) adapter.

3.3.1 Testing an SI Device

Example 3-4 is a sample test session of an SI device. The device tested is a disk associated with the KDM70 adapter.

### Example 3-4 Testing an SI Device

P00>>> show	device	0			
polling for	units	on kdm700,	slot	11,	xmi0
duc1.0.0.11.	2	DUC1			RA70
duc2.0.0.11.	2	DUC2			RA70
duc3.0.0.11.	2	DUC3			RA70
duc213.0.0.1	1.2	DUC213			RA82

P00>>> set host -dup duc1.0.0.11.2 () dup: starting DIRECT on kdm70\_c.0.0.11.2 ()

DIRECT 1 D Directory Utility

ILEXER 1 D InLine Exerciser

Task? ilexer 3 dup: starting ILEXER on kdm70\_c.0.0.11.2 ()

- **1** Type **show device** to obtain a list of disks and device mnemonics.
- **2** Enter **set host** -**dup** to connect to the disk you want to test. In the example, the disk with the mnemonic duc1.0.0.11.2 is selected. The DUP program prompts you to select Directory Utility or InLine Exerciser.
- **3** Type **ilexer** to start the inline exerciser.

For more information:

KDM70 Controller User Guide

KDM70 Controller Service Manual

### Example 3-4 Testing an SI Device (Continued)

```
***
*** ILEXER (InLine Exerciser) V 001 *** 17-NOV-1992 03:10:28 ***
* * *
Enable Bad Block Replacement (Y/N) [N] ? 4
Available Disk Drives: D0001 D0002 D0003 D0213
Available Tape Drives: NONE
Select next drive to test (Tnnnn/Dnnnn) [] ? d0003 5
Write enable drive (Y/N) [N] ?
*** Available tests are:
   1. Random I/O
    2. Seek Intensive I/O
   3. Data Intensive I/O
   4. Oscillatory Seek
Select test number (1:4) [1] ?
Select start block number (0:547040) [0] ?
Select end block number (0:547040) [547040] ?
Select data pattern number 0=ALL (0:15) [0] ?
Select another drive (Y/N) [] ? n
Select execution time limit, 0=Infinite, minutes (0:65535) [0] ? 1
Select report interval, minutes (0:65535) [1] ?
Select hard error limit (0:32) [0] ?
Report soft errors (Y/N) [N] ?
            Execution Performance Summary at 17-NOV-1992 03:12:36 6
D0003
           193531233
                        1998
                                  4508
                                               0
                                                     0
                                                           0
                                                                0
 0
               8
                         9
                                   Ð
                                               1
                                                     Ð
                                                          B
                                                                Ð
            Execution Performance Summary at 17-NOV-1858 00:02:37
D0003 *
           193531233
                        2003
                                  4513
                                             0
                                                     0
                                                           0
                                                                0
* * *
*** ILEXER is exiting.
* * *
```
- **4** You are prompted to answer a series of questions before testing can begin.
- **③** Indicate the disk drive to be tested.
- **6** The execution performance summary line includes the following entries:
  - **7** Unit number
  - **8** Unit serial number
  - **9** Number of requests issued
  - Kbytes read
  - **(b)** Kbytes written
  - Hard error count
  - **(B)** Soft error count
  - **ECC** error count

#### 3.3.2 Testing a DSSI Device

Example 3-5 is a sample test session of a DSSI device. The device tested is a disk associated with the KFMSA adapter.

#### Example 3-5 Testing a DSSI Device

```
P00>>> set host -dup duc1.1.0.13.3 1
dup: starting DIRECT on kfmsa_c.1.0.13.3 (R2UJBC) 2
Copyright (C) 1990 Digital Equipment Corporation
PRFMON V1.0 D 20-FEB-1991 09:49:00 3
DKCOPY V1.0 D 20-FEB-1991 09:49:00
DRVEXR V2.0 D 20-FEB-1991 09:49:00
DRVTST V2.0 D 20-FEB-1991 09:49:00
HISTRY V1.1 D 20-FEB-1991 09:49:00
DIRECT V1.0 D 20-FEB-1991 09:49:00
ERASE V2.0 D 20-FEB-1991 09:49:00
VERIFY V1.0 D 20-FEB-1991 09:49:00
DKUTIL V1.0 D 20-FEB-1991 09:49:00
PARAMS V2.0 D 20-FEB-1991 09:49:00
Total of 10 programs.
Task? drvtst 🖪
dup: starting DRVTST on kfmsa_c.1.0.13.3 (R2UJBC)
Copyright (C) 1990 Digital Equipment Corporation
Write/read anywhere on medium? [1=Yes/(0=No)] 0 5
  5 minutes to complete. 6
R2UJBC::MSCP$DUP 5-MAR-1991 11:13:11 DRVTST CPU= 0 00:00:13.72 PI=248
R2UJBC::MSCP$DUP 5-MAR-1991 11:13:41 DRVTST CPU= 0 00:00:28.00 PI=506
R2UJBC::MSCP$DUP 5-MAR-1991 11:14:12 DRVTST CPU= 0 00:00:42.48 PI=765
R2UJBC::MSCP$DUP 5-MAR-1991 11:14:42 DRVTST CPU= 0 00:00:57.03 PI=1024
R2UJBC::MSCP$DUP 5-MAR-1991 11:15:12 DRVTST CPU= 0 00:01:11.30 PI=1282
R2UJBC::MSCP$DUP 5-MAR-1991 11:15:43 DRVTST CPU= 0 00:01:25.62 PI=1541
R2UJBC::MSCP$DUP 5-MAR-1991 11:16:13 DRVTST CPU= 0 00:01:40.13 PI=1800
R2UJBC::MSCP$DUP 5-MAR-1991 11:16:43 DRVTST CPU= 0 00:01:54.63 PI=2059
R2UJBC::MSCP$DUP 5-MAR-1991 11:17:14 DRVTS CPU= 0 00:02:08.94 PI=2318
Test passed.
Task? 7
P00>>>
```

- **1** Enter **set host** -**dup** to connect to the disk you want to test. In the example, the disk with the mnemonic **duc1.1.0.13.3** is selected.
- **2** A message confirms that the connection has been made.
- **3** The DUP test programs are listed.
- **4** In response to the user input, the test program **drvtst** is started.
- **③** The user types **0** in response to this question.
- **6** Testing begins.
- Press RETURN to exit from the DUP program. The console prompt returns.

For more information:

KFMSA Module Service Guide

# Appendix A

# Parse Trees

This appendix shows parse trees. An example showing how to read the parse trees is provided. This appendix includes:

- Reading Parse Trees
- KA7AA Machine Checks (Figure A-1)
- KA7AA Hard Error Interrupts (Figure A-2)
- KA7AA Soft Error Interrupts (Figure A-3)
- IOP Interrupts (Figure A-4)
- DWLMA Interrupts (Figure A-5)

## A.1 Reading Parse Trees





A parse tree represents the way the system "sorts" an error condition. The four types of error conditions are machine check, hard error (INT60), soft error (INT54), and IPL 17 errors for the IOP module and the DWLMA adapter.

In Example A-1, a machine check error occurred. In the error report, the error was identified as a MCHK\_SYNC\_ERROR () with a code number of 06 (2).

There are many conditions that can cause a MCHK\_SYNC\_ERROR. To determine what caused the error, follow this branch of the parse tree and evaluate each condition. The first condition under MCHK\_SYNC\_ERROR is ICSR.LOCK ( ③). If the ICSR.LOCK bit was set, you would then branch off and evaluate each condition under ICSR.LOCK to determine the type of error. In this case, there are three types of errors: VIC data parity error, VIC tag parity error, and inconsistent error.

# *NOTE:* Inconsistent errors are usually fatal errors since the machine state is not understood.

If the ICSR.LOCK bit was not set, you would advance to the next error condition, not PCSRS.PTE\_ER ( a). If this condition was met, you would branch off here and evaluate the conditions listed on this branch of the parse tree.



### Figure A-1 KA7AA Machine Check Parse Tree



Figure A-1 KA7AA Machine Check Parse Tree (Continued)



### Figure A-1 KA7AA Machine Check Parse Tree (Continued)



Figure A-1 KA7AA Machine Check Parse Tree (Continued)













BIU\_STAT.BIU\_DSP\_CMB<6:4>=Loadlock IMERR.ARBDROP<10> PTE read ARB drop IMERR.BTAGPE<5> PTE LEVI B-cache tag parity error (lookup) IMERR.BSTATPE<4> PTE LEVI B-cache status parity error (lookup) Else Inconsistent LBER.E<0> and LBECR.CA<37:35> = Read and LBECR1.CID<10:7> = This\_CPU (Memory data) LBER.NXAE<12> PTE write LSB NXM LBER.CPE<5> PTE LSB command parity error Else Inconsistent LBER.E Previous system error latched Else Inconsistent

BXB-0314-92



Figure A-2 KA7AA Hard Error Interrupts







Figure A-2 KA7AA Hard Error Interrupts (Continued)



### Figure A-2 KA7AA Hard Error Interrupts (Continued)



Figure A-2 KA7AA Hard Error Interrupts (Continued)



### Figure A-2 KA7AA Hard Error Interrupts (Continued)











Figure A-3 KA7AA Soft Error Interrupts



### Figure A-4 IOP Interrupts



Figure A-4 IOP Interrupts (Continued)

## Figure A-5 DWLMA Interrupts

	L17 /LMA	
	XBER.NSES<12>	
	LBERR.DHDPE<28>	<ul> <li>DOWN channel data parity error</li> </ul>
	LBERR.MBPE<14>	Mailbox parity error
	LBERR.MBIC<13>	
	LBERR.MBIA<12>	
	LBERR.DFDPE<6>	DOWN channel FIFO
	LBERR.RBDPE<5>	data parity error
	LBERR.MBOF<4>	Read buffer data parity error
	LBERR.FE<3>	<ul> <li>Mailbox overflow</li> </ul>
	Fise	<ul> <li>DWLMA fatal error</li> </ul>
		<ul> <li>Inconsistent</li> </ul>
	XBER.E<31>	
	XBER.WEI<25>	XMI write error interrupt
	XBER.CC<27>	
	XBER.IPE<24>	<ul> <li>XIVII corrected confirmation</li> </ul>
	XBER.CRD<19>	<ul> <li>XMI inconsistent parity error</li> </ul>
	XBER.REP<16>	<ul> <li>XMI corrected read data response</li> </ul>
	LBER.RSE<17>	<ul> <li>XMI read error response</li> </ul>
	XBER.PE<23>	
	Else	<ul> <li>Read sequence error parity error</li> </ul>
		Read sequence error
(1	)(2)	BXB-0333-92



Figure A-5 DWLMA Interrupts (Continued)

BXB-0334-92

# Appendix B

# **Power System Troubleshooting**

This appendix provides guidelines for troubleshooting the power system. Sections include:

- Getting Information on Power Regulator Status
- Show Power Command
- Checking the IOP Module During Power-Up
- Identifying an LSB Module Power Converter Failure

## **B.1 Getting Information on Power Regulator Status**

Typing a command packet at the console terminal when the console is not running provides you with detailed information about the power system. Figure B-1 shows the command packet structure. Each power regulator has a unique address, determined by its location in the DC distribution box (slot A, B, or C).

NOTE: You must type in upper case when entering a command packet.





#### **Entering a Command Packet**

To enter a command packet at the console terminal:

- 1. Enter the packet header by typing Ctrl/B two times.
- 2. Type the 1-letter command.
- 3. Type the power regulator identification letter.
- 4. Enter the packet terminator by typing Ctrl/M.

### **B.1.1 Brief Data Packet**

Data packets sent from the power regulator in response to a B (brief current status) command are a stream of nine ASCII characters consisting of four parts:

- 1. Packet header One ASCII character. The power regulator transmits an A, B, or C, depending on its slot position.
- 2. Packet Data Two ASCII characters representing the remaining battery capacity in minutes.
- 3. Packet State Four ASCII characters which provide the heatsink status, battery pack state, test status, and power supply state.
- 4. Packet Terminator Two ASCII characters representing the checksum to determine data packet errors.

Figure B-2 shows the brief data packet structure.

Table B-1 lists the meaning of each value in the following example of a brief data packet:

### A|23|0|-|P|1|84

The character format is 8 bits, no parity, with one stop bit. The baud rate is 9600.

Character	Value	Information
1	А	Data packet from power regulator A
2–3	23	Battery capacity remaining = 23 minutes
4	0	Heatsink temperature within range
5	_	Battery pack discharging
6	Р	Last battery pack test completed successfully
7	1	BBU mode
8-9	84	Checksum value

 Table B-1
 Sample Brief Packet Information





### **B.1.2 Full Data Packet**

A data packet in response to an S (full current status)/H (history) command is a single stream of 54 ASCII characters consisting of four parts:

- 1. Packet header Six ASCII characters
- 2. Packet data 42 ASCII characters representing 11 parameters
- 3. Packet state Four ASCII characters which provide the heatsink status, battery pack state, test status, and power supply state
- 4. Packet terminator Two ASCII characters which represent the checksum to determine data packet errors

The following figures show the full/history data packet structure. The character format is 8 bits, no parity, with one stop bit. The baud rate is 9600.

#### Figure B-3 Full Data Packet Structure



BXB-0271-92

### Figure B-4 Full Data Packet: Values for Characters 1–6





#### Figure B-5 Full Data Packet: Values for Characters 7–34

BXB-0273-92



### Figure B-6 Full Data Packet: Values for Characters 35–47

BXB-0274-92


Figure B-7 Full Data Packet: Values for Characters 48–54

Table B-2 lists the meaning of each value in the following example of a full/history data packet:

1 30 54 [A]L]01]11]0778]0444]0960]0600]0867]0867]0000]0540]0623]23]08]00]0]F]P]0]A8

Character	Value	Information
1	А	Data packet from power regulator A
2	L	30-33798-01
3-4	01	Primary micro firmware revision = 0.1
5-6	11	Secondary micro firmware revision = 1.1
7–10	0778	Peak AC line voltage = 152 volts
11-14	0444	DC bulk voltage = 159 volts
15-18	0960	48 VDC bus voltage = 46.8 volts
19-22	0600	48 VDC bus current = 29.3 amps
23-26	0867	48V battery pack voltage = 50.8 volts
27-30	0867	24V battery pack voltage = 25.4 volts
31-34	0000	Battery pack discharge current = 0.0 amps
35-38	0540	Ambient temperature = 26.3 degrees Celsius
39-42	0623	Elapsed run time = 6230 hours
43-44	23	Remaining battery capacity = 23 minutes
45-46	08	Battery discharge time = 8 minutes
47-48	00	Spare
49	0	Heatsink temperature within range
50	F	Battery pack fully charged
51	Р	Last battery pack test completed successfully
52	0	Normal operation
53-54	A8	Checksum value

#### Table B-2 Sample Full/History Packet Information

## **B.2 Show Power Command**

As shown in Example B-1, the **show power** command can be used to display the power status of the system. The bottom three lines of the output, showing PIU power status, are printed for the main cabinet only.

#### Example B-1 Sample Output, Show Power Command

>>> show power				
Cabinet: Main Regulator :	:	A	В	C
Primary Micro Firmware Rev	:	2.0	2.0	2.0
Secondary Micro Firmware Rev	:	2.0	2.0	2.0
Power Supply State	:	NORMAL	NORMAL	BBU MODE
AC Line Voltage (V RMS)	:	113.71	114.35	115.93
DC Bulk Voltage (VDC)	:	227.02	227.02	227.02
48V DC Bus Voltage (VDC)	:	47.57	47.57	47.57
48V DC Bus Current (ADC)	:	30.17	29.68	29.58
48V Battery Pack Voltage (VDC)	:	50.85	50.72	47.91
24V Battery Pack Voltage (VDC)	:	25.56	25.56	23.95
Battery Pack Charge Current (IDC)	:	2.91	2.90	0
Ambient Temperature (Degree C)	:	26.22	24.80	24.75
Elapsed Time (Hours)	:	290.00	290.00	290.00
Remaining Battery Capacity (Minutes)	:	60.00	60.00	60.00
Battery Cutoff Counter (Cycles)	:	0	1.00	1.00
Battery Configuration	:	8 Batteries	8 Batteries	8 Batteries
Heatsink Status	:	NORMAL	NORMAL	NORMAL
Battery Pack Status	:	CHARGING	CHARGING	DISCHG'G
Last UPS Test Status	:	PASSED	PASSED	TESTING
LDC POWER Status : 0				
PIU Primary Status : 0				
PIU Secondary Status : 0				

# B.3 Checking the IOP Module During Power-Up

If the console hangs with no error indication during power-up, check the oscillator switch settings on the IOP module. To access the oscillator switch:

- 1. Open the rear door of the cabinet and release the plate covering the LSB card cage by loosening the two top screws.
- 2. Slide the IOP module out of the LSB card cage so that you can visually check the oscillator switch settings. Figure B-8 shows the location of the oscillator switch on the IOP module. Figure B-9 shows the correct settings on the IOP oscillator switch.





BXB-0356A-92

#### Figure B-9 IOP Oscillator Switch Settings



## B.4 Identifying an LSB Module Power Converter Failure

Each LSB module converts 48 volts to 5 volts on the module. If a module power converter fails, damage to the LSB bus is prevented by disabling the 2V reference voltage at all LSB nodes. The self-test LED on the failing LSB module remains unlit.

If the control panel Fault light remains lit and the console prompt is displayed, then the LSB is good and the failing module is indicated by its selftest LED. If the IOP LED (see Figure B-8) remains off in a uniprocessor system, then the CPU should be presumed bad.

Table B-3 lists the state of the self-test LEDs when a processor, memory, or IOP module power converter fails.

Failing Module	Other CPU LEDs are	Other Memory LED is	IOP LED is
CPU Self-test LED Off	On	On	Off
Memory Self-test LED Off	On	On	Off
IOP Self-test LED Off	On	On	Off

Table B-3 LED Status When a Power Converter Fails

# Index

#### Α

AC input box indicators, 1-6 location, 1-6 troubleshooting, 1-7

#### В

Blower location, 1-14 troubleshooting, 1-15

## С

CCL module LEDs, 1-10 location, 1-10 troubleshooting, 1-10 Clock card LED, 2-31 Control panel keyswitch, 1-12 LEDs, 1-12 troubleshooting, 1-13

## D

DSSI devices, 3-12 DWLMA adapter LEDs, 2-31

## Ε

Exercisers, 3-3

#### Η

H7263 power regulator checking status, B-3 LEDs, 1-8 location, 1-8 troubleshooting, 1-9

## I

IOP module oscillator switch settings, B-13 power converter failure, B-15 accessing the, 2-31 LED, 2-30

## Μ

Memory module power converter failure, B-15 LEDs, 2-25

# 0

Oscillator switch, B-13

## Ρ

Parse trees DWLMA interrupts, A-22 IOP interrupts, A-20 KA7AA hard error interrupts, A-11 KA7AA machine check, A-4 KA7AA soft error interrupts, A-19 Power system command packets, B-3 data packets, B-3 requirements, B-2 show power command, B-13 Processor power converter failure, B-15 diagnostic LEDs, 2-24 interpreting diagnostic LEDs, 2-27

#### R

ROM-based diagnostics testing XMI devices, 3-4

## S

```
SI devices, 3-8
System self-test
checking results of, 2-10
console display, 2-12
control panel Fault LED,
2-11
module LEDs, 2-24
overview, 2-2
```

## Т

Test command, 3-2

# Х

XMI plug-in unit location, 1-16 power connector, 1-19 power regulators, 1-16 switches and LEDs, 1-16 troubleshooting, 1-18